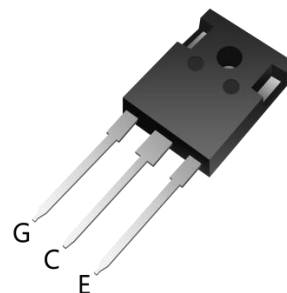
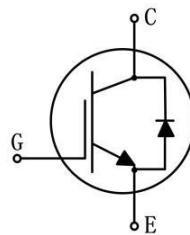


Trench Field-stop IGBT Discrete

Parameter	Value	Unit
V_{CE}	650	V
I_C	60	A
$V_{CE(sat)}$	1.6	V



TO-247-3L

Features

- Trench and field-stop technology
- Easy parallel switching capability

Applications

- Energy storage
- Solar string inverter
- Uninterruptible power supplies

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CES}	650	V
Gate-emitter voltage	V_{GES}	± 20	V
Continuous collector current($T_C=25^\circ\text{C}$)	I_C	120	A
Continuous collector current($T_C=100^\circ\text{C}$)		60	A
Pulsed collector current, tp limited by T_{vjmax}	I_{CM}	240	A
Diode continuous forward current($T_C=100^\circ\text{C}$)	I_F	60	A
Diode maximum current, tp limited by T_{vjmax}	I_{FM}	240	A
Power dissipation($T_C=25^\circ\text{C}$)	P_{tot}	375	W
Power dissipation($T_C=100^\circ\text{C}$)		145	W
Operating junction temperature range	T_{vj}	-55 to +175	$^\circ\text{C}$
Storage temperature range	T_{stg}	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Value		Unit
		Typ	Max.	
Thermal resistance, junction to case for IGBT	$R_{th(j-c)}$	-	0.4	$^\circ\text{C/W}$
Thermal resistance, junction to case for Diode	$R_{th(j-c)}$	-	0.7	$^\circ\text{C/W}$
Thermal resistance, junction to ambient	$R_{th(j-a)}$	-	40	$^\circ\text{C/W}$

Electrical Characteristics of IGBT ($T_{vj}=25^{\circ}\text{C}$ unless otherwise specified)
Static characteristics

Parameter	Symbol	Test condition	Value			Unit
			Min.	Typ.	Max.	
Collector-emitter breakdown voltage	BV_{CES}	$V_{GE}=0V, I_C=250\mu A$	650	-	-	V
Collector-emitter leakage current	I_{CES}	$V_{CE}=650V, V_{GE}=0V$	-	-	25	μA
Gate leakage current, forward	I_{GES}	$V_{GE}=\pm 20V, V_{CE}=0V$	-	-	± 200	nA
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE}=V_{CE}, I_C=1mA$	4.7	5.5	6.2	V
Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{GE}=15V, I_C=60A$	-	1.6	2	V
		$V_{GE}=15V, I_C=60A$	-	2.5	-	V

Dynamic Characteristics

Parameter	Symbol	Test condition	Value			Unit
			Min.	Typ.	Max.	
Input capacitance	C_{ies}	$V_{CE}=25V$	-	3146	-	pF
Output capacitance	C_{oes}	$V_{GE}=0V$	-	121	-	pF
Reverse transfer capacitance	C_{res}	$f=1MHz$	-	31	-	pF
Total gate charge	Q_g	$V_{CC}=520V, V_{GE}=15V, I_C=60A$	-	118	-	nC

Switching Characteristics

Parameter	Symbol	Test condition	Value			Unit
			Min.	Typ.	Max.	
Turn-on delay time	$t_{d(on)}$	$V_{CC}=400V$ $V_{GE}=15V$ $I_C=60A$ $R_G=5\Omega$ Inductive load	-	44	-	ns
Rise time	t_r		-	47	-	ns
Turn-off delay time	$t_{d(off)}$		-	123	-	ns
Fall time	t_f		-	90	-	ns
Turn-on energy	E_{on}		-	1.2	-	mJ
Turn-off energy	E_{off}		-	1.5	-	mJ
Total switching energy	E_{ts}		-	2.7	-	mJ
Turn-on delay time	$t_{d(on)}$	$V_{CC}=400V$ $V_{GE}=15V$ $I_C=60A$ $R_G=5\Omega$ Inductive load $T_{vj}=175^{\circ}\text{C}$	-	36	-	ns
Rise time	t_r		-	46	-	ns
Turn-off delay time	$t_{d(off)}$		-	140	-	ns
Fall time	t_f		-	150	-	ns
Turn-on energy	E_{on}		-	1.3	-	mJ
Turn-off energy	E_{off}		-	2.34	-	mJ
Total switching energy	E_{ts}		-	3.64	-	mJ

Diode Characteristics

Parameter	Symbol	Test condition	Values			Unit
			Min.	Typ.	Max.	
Diode forward voltage	V_F	$I_F=60A$	-	1.7	2.4	V
		$I_F=60A, T_{vj}=175^{\circ}C$	-	1.45	-	V
Diode reverse recovery time	t_{rr}	$V_R=400V$	-	41	-	ns
Diode peak reverse recovery current	I_{rrm}	$I_F=60A$	-	3.3	-	A
Diode reverse recovery charge	Q_{rr}	$diF/dt=-450A/\mu s$	-	70	-	nC
Diode reverse recovery time	t_{rr}	$V_R=400V$	-	219	-	ns
Diode peak reverse recovery current	I_{rrm}	$I_F=60A$	-	11.5	-	A
Diode reverse recovery charge	Q_{rr}	$diF/dt=-450A/\mu s, T_{vj}=175^{\circ}C$	-	1454	-	nC

Typical Characteristics

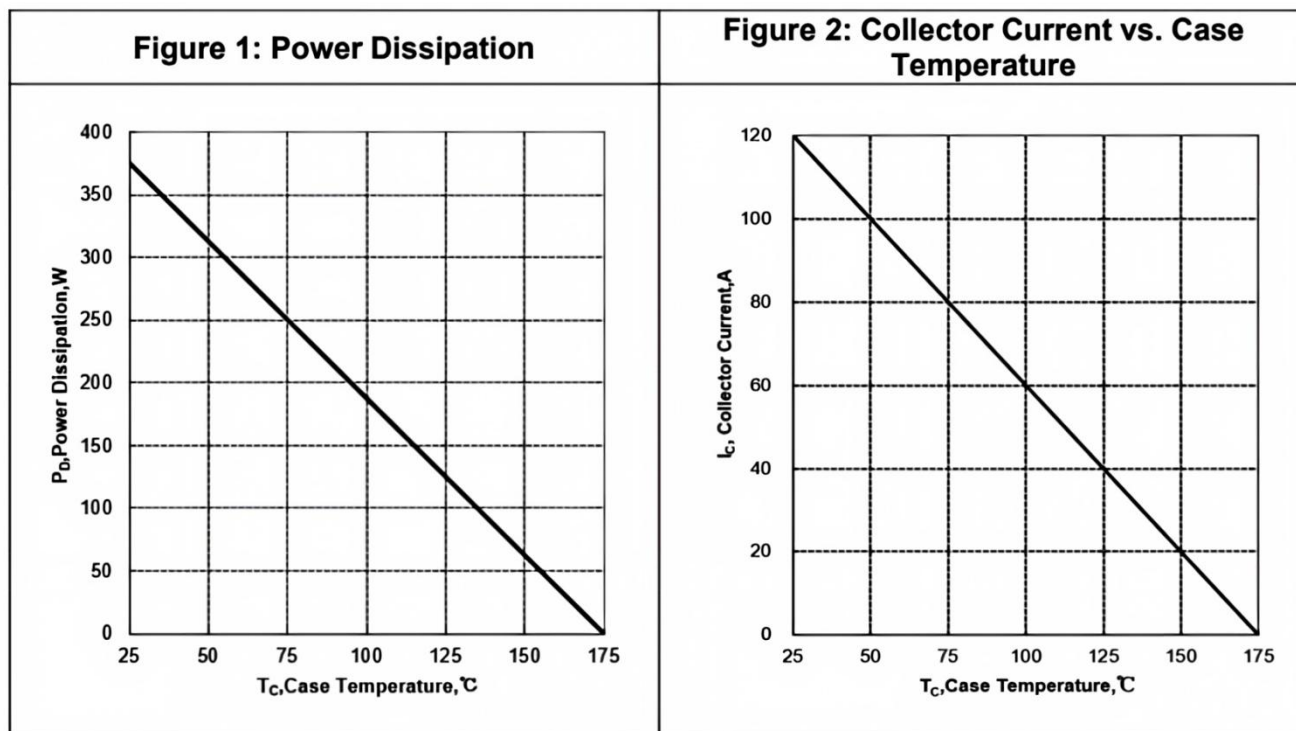


Figure 3: Safe Operation Area

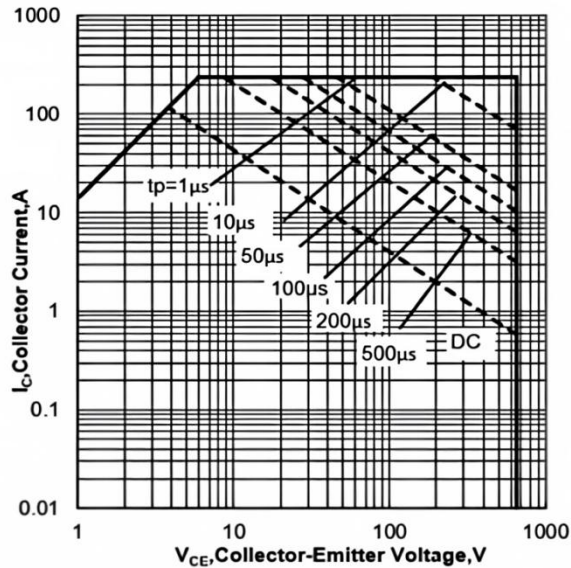


Figure 4: Typical Transfer Characteristics

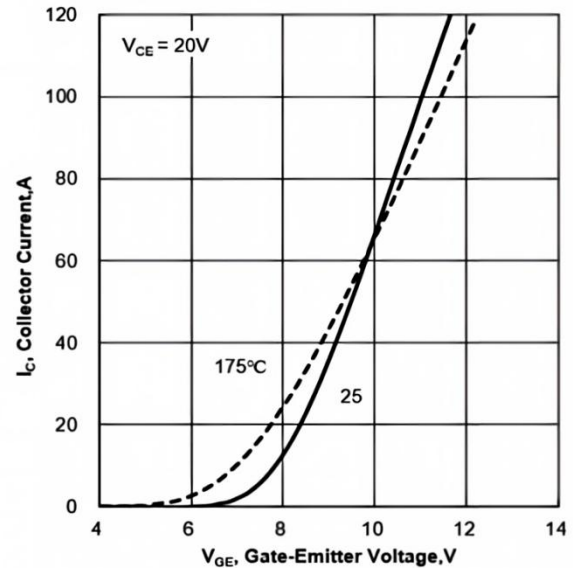


Figure 5: Typical Output Characteristics

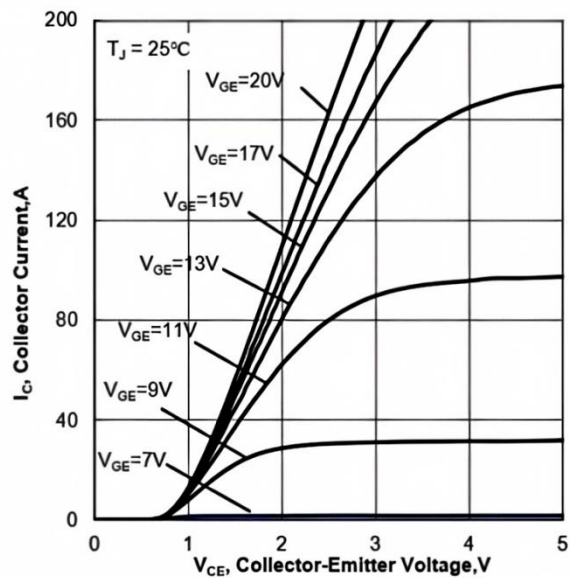


Figure 6: Typical Output Characteristics

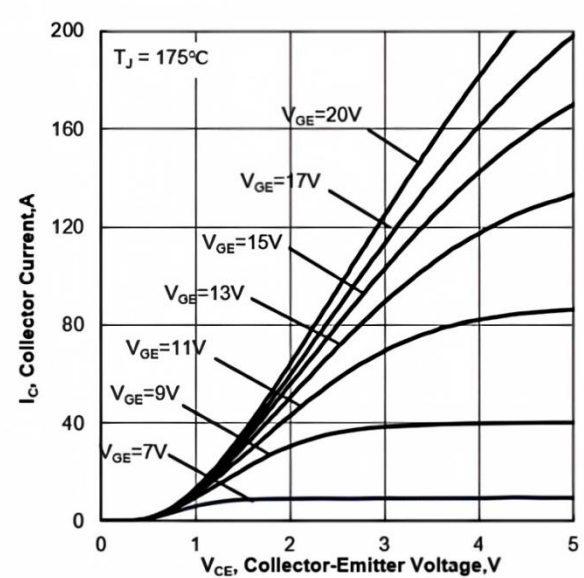


Figure 7: Typical Collector-Emitter Saturation Voltage vs. Junction Temperature

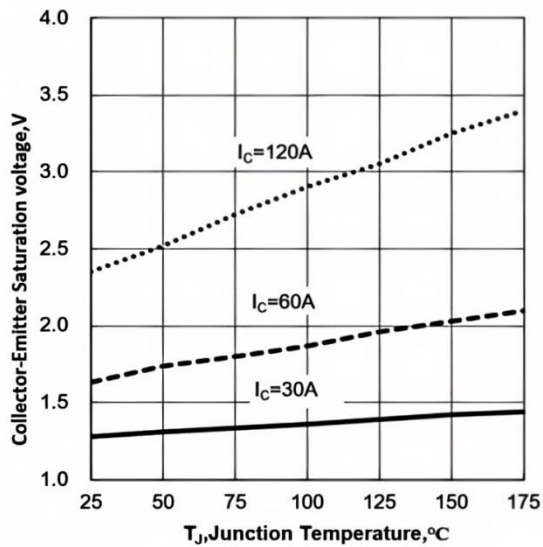


Figure 8: Typical Gate-Emitter Threshold Voltage vs. Junction Temperature

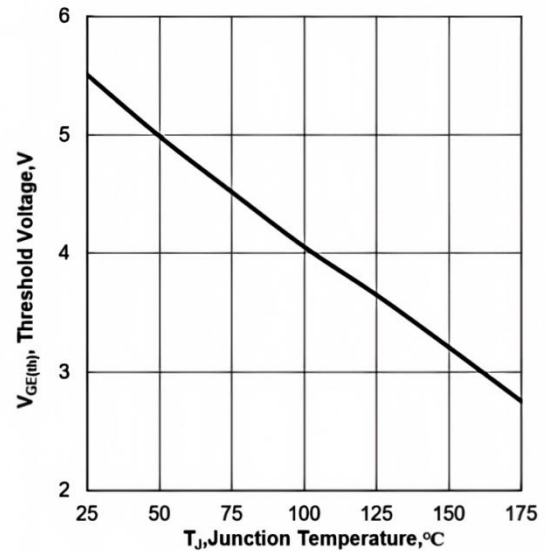


Figure 9: Typical Switching Times vs. Gate Resistor ($T_J=25^{\circ}C$, $V_{CE}=400V$, $V_{GE}=15V$, $I_C=60A$)

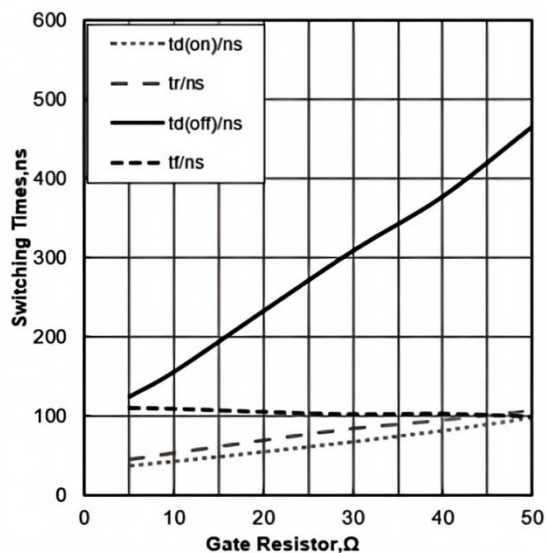


Figure 10: Typical Switching Energy vs. Gate Resistor ($T_J=25^{\circ}C$, $V_{CE}=400V$, $V_{GE}=15V$, $I_C=60A$)

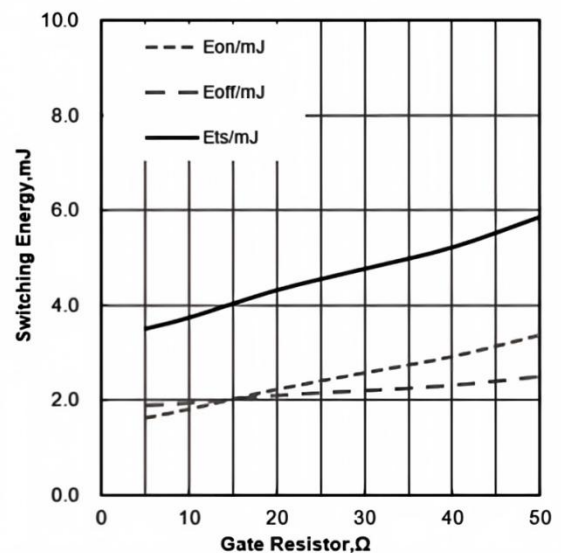


Figure 11: Typical Switching Times vs. Junction Temperature ($V_{CE}=400V$, $V_{GE}=15V$, $I_C=60A$, $R_g=5\Omega$)

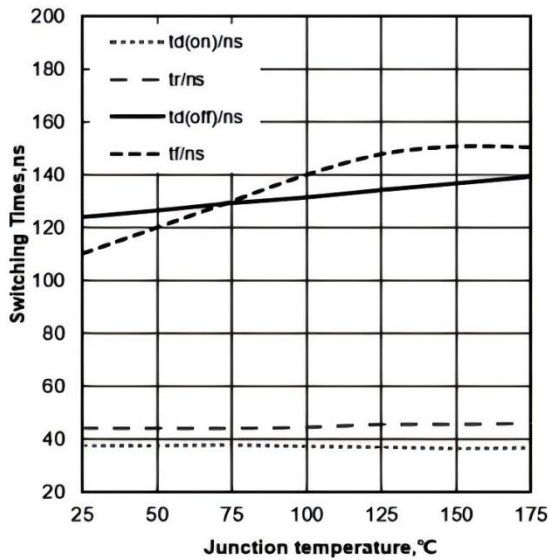


Figure 12: Typical Switching Energy vs. Junction Temperature ($V_{CE}=400V$, $V_{GE}=15V$, $I_C=60A$, $R_g=5\Omega$)

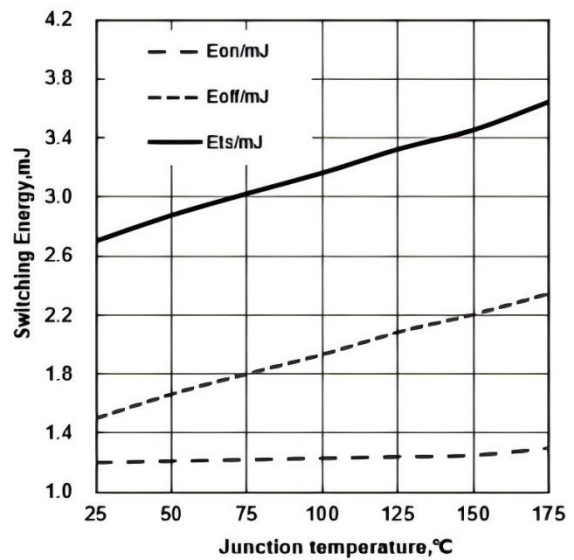


Figure 13: Typical Switching Times vs. Collector Current ($T_J=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15V$, $R_g=5\Omega$)

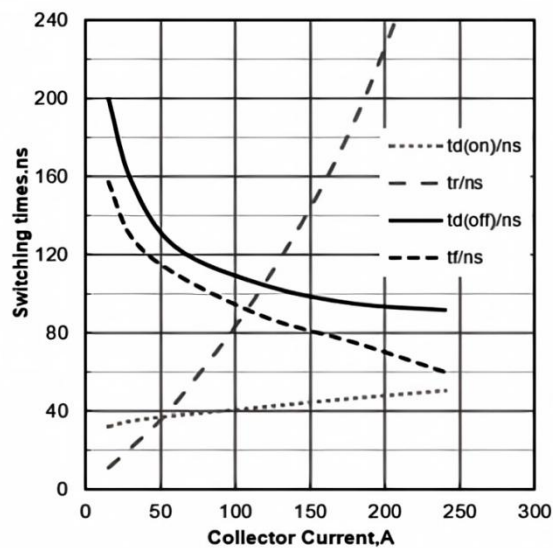


Figure 14: Typical Switching Energy vs. Collector Current ($T_J=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15V$, $R_g=5\Omega$)

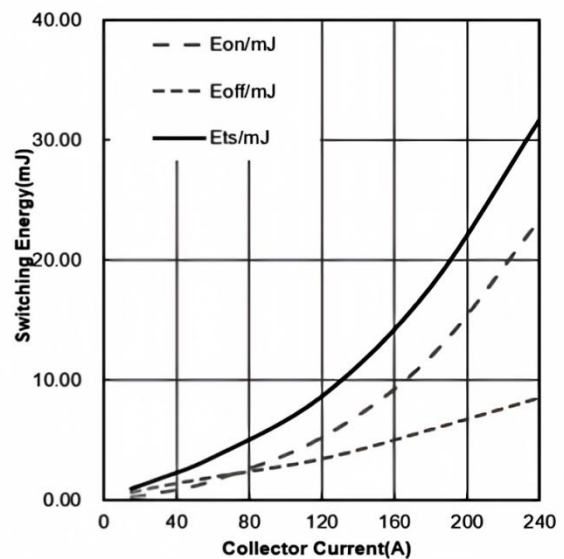


Figure 15: Typical Switching Times vs. VCE
($T_J=25^{\circ}\text{C}$, $V_{GE}=15\text{V}$, $I_C=60\text{A}$, $R_g=5\Omega$)

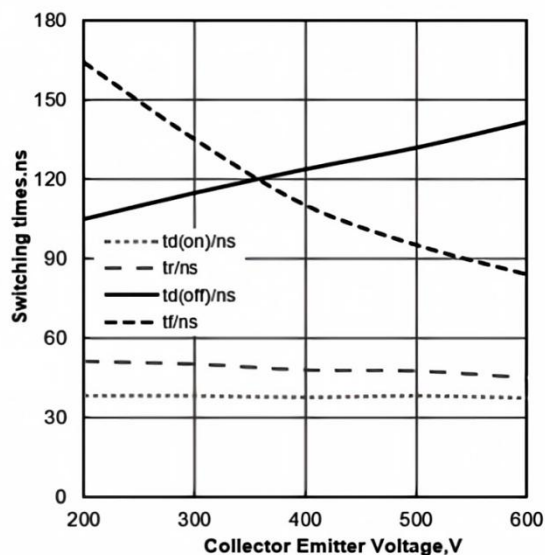


Figure 16: Typical Switching Energy vs. VCE
($T_J=25^{\circ}\text{C}$, $V_{GE}=15\text{V}$, $I_C=60\text{A}$, $R_g=5\Omega$)

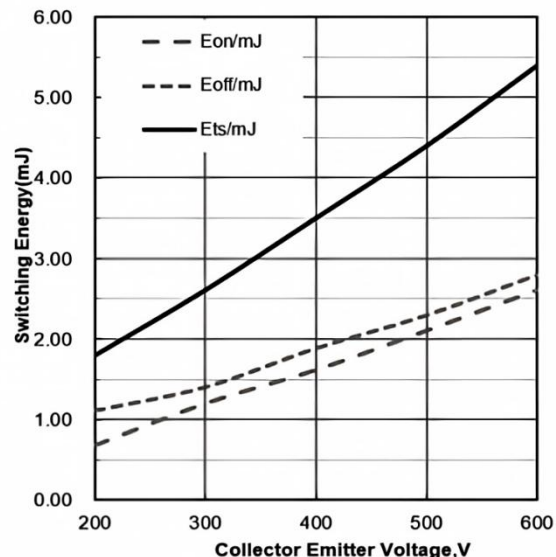


Figure 17: Typical Capacitance vs. Collector- Emitter Voltage

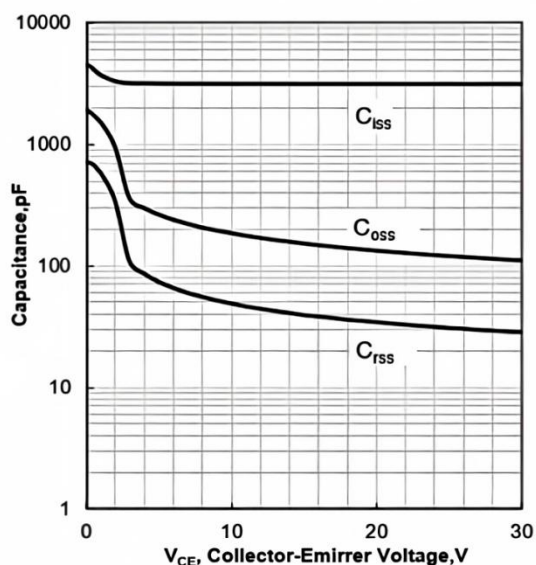


Figure 18: Typical Gate Charge

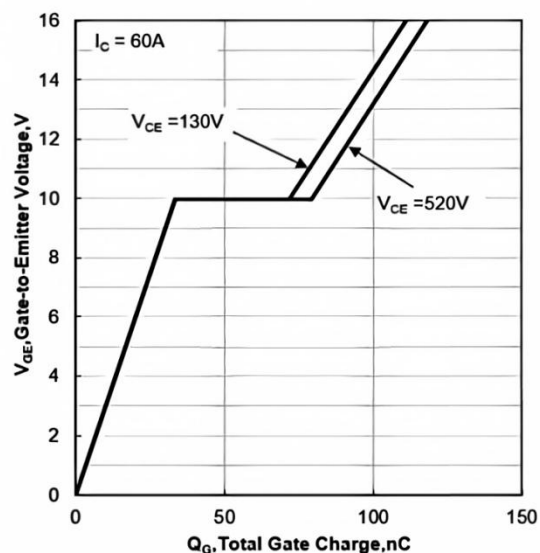


Figure 19: IGBT Transient Thermal Impedance vs. Pulse Width

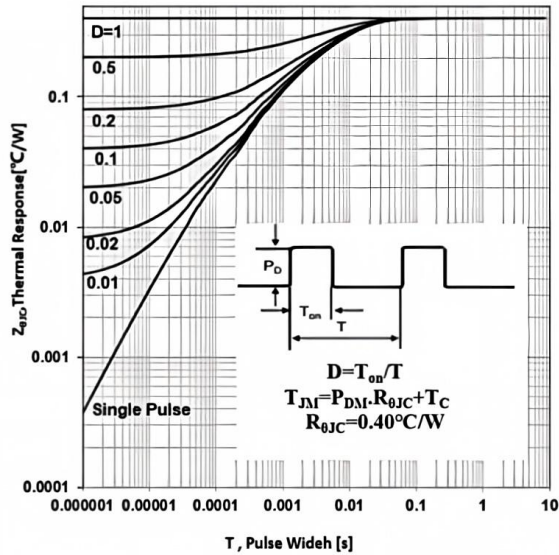


Figure 20: Diode Transient Thermal Impedance vs. Pulse Width

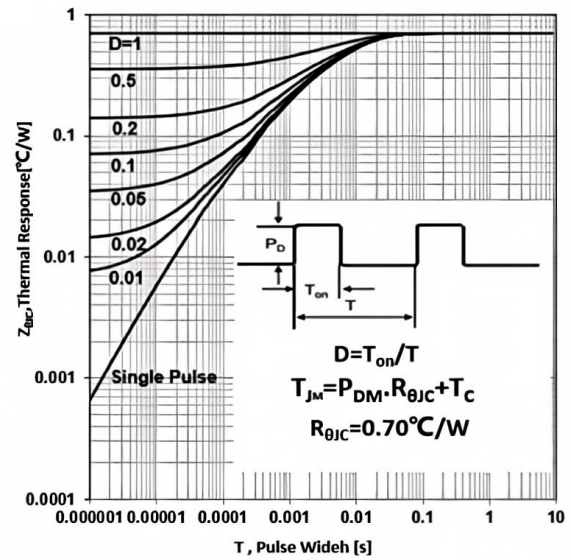
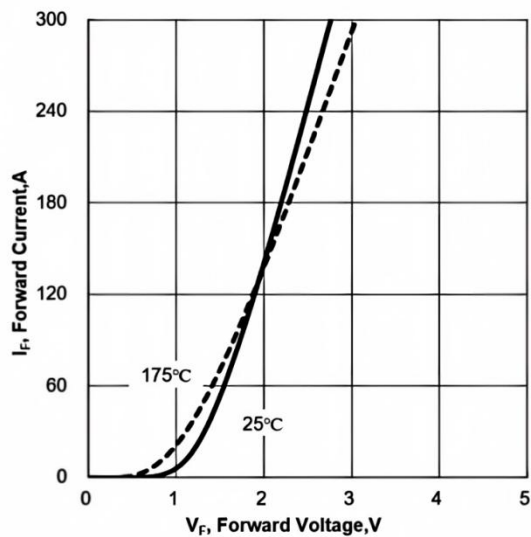
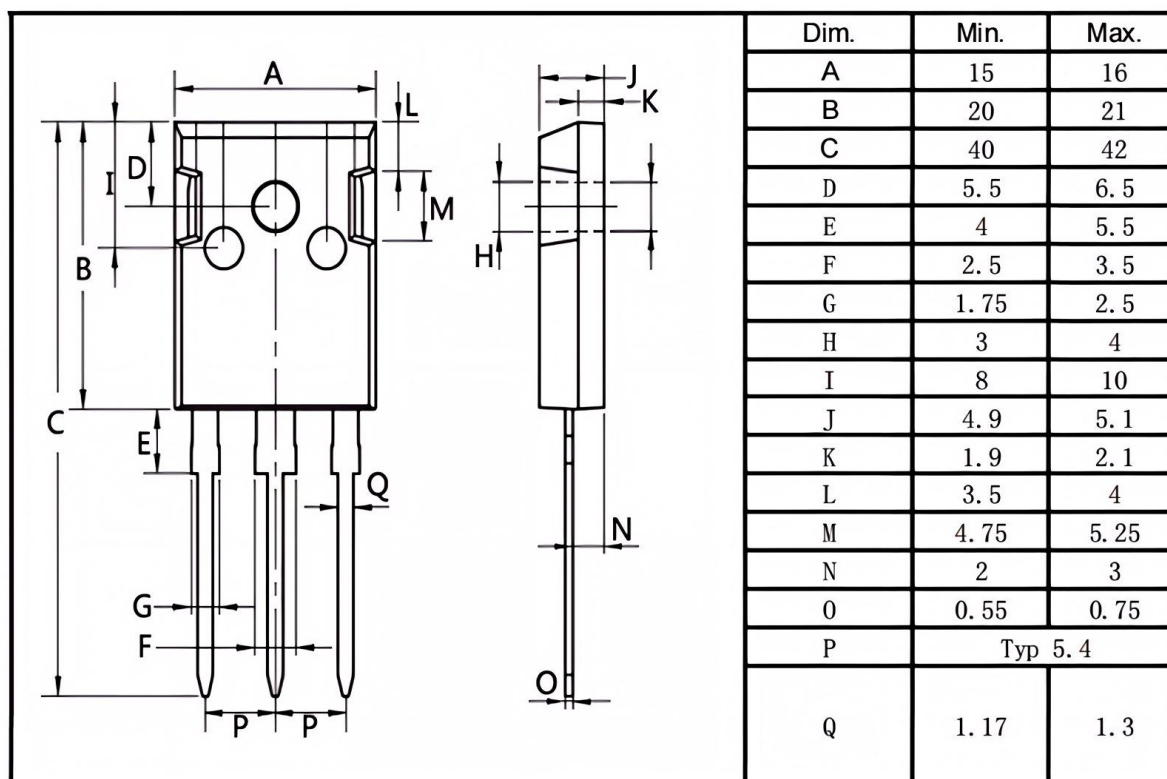


Figure 21: Typical Diode Forward Current vs. Forward Voltage



Package Outline Dimensions

TO-247-3L



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